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Phosphate structure and lithium environments in lithium phosphorus oxynitride amorphous thin films

M. A. Carrillo Solano^{1,2} · M. Dussauze³ · P. Vinatier² · L. Croguennec² · E. I. Kamitsos⁴ · R. Hausbrand¹ · W. Jaegermann¹

Abstract Lithium ion-conducting glasses attract wide interest for electrochemical applications like efficient energy storage devices. This work presents a structural study on involved bonding units, based on X-ray photoelectron spectroscopy and infrared spectroscopy, of lithium phosphorus oxide and oxynitride amorphous thin films prepared by RF magnetron sputtering. A thorough consideration of the mid- and far-infrared spectral regions demonstrated structural changes at the phosphate units and the lithium ion environments triggered by nitrogen incorporation and post-deposition thermal treatment. It was found that films prepared by sputtering in pure nitrogen atmosphere have about 75 % of their nitrogen atoms in sites doubly coordinated with phosphorus (P–N=P), and the rest in triply coordinated sites. It was shown also that nitrogen incorporation favors the stability of lithium ions, while annealing enhances ionic conductivity of the oxynitride films.

Keywords LiPON · IR spectroscopy · Thin film · Lithium phosphorus oxynitride · Glasses

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Introduction

Amorphous ion-conducting films have properties that are appealing for advanced technological applications. The importance of developing these materials as thin films is evident from recent advances in solid-state electrochemical applications. Due to its favorable electrical properties and good electrochemical stability, lithium phosphorus oxynitride (LiPON) glass serves as a good option to be implemented as amorphous electrolyte in all solid-state lithium ion batteries.

The techniques used to produce amorphous thin films include evaporation, pulsed laser deposition (PLD), and sputtering [1–8]. Depending on process conditions and preparation method, thin film materials with different chemical composition, structure, and properties can be made. Several studies comparing the properties of bulk glasses, prepared with traditional melt quenching technique, and thin film amorphous materials, deposited with sputtering, have been made [9, 10]. Even though both materials had the same nominal composition, differences in the short-range order were reported. In this context, thin film engineering technology has many challenges to overcome in order to fully understand the process by which glassy materials are deposited and thus to correlate composition, structure, and properties with the deposition parameters [11–19].

Most amorphous oxide-based thin films exhibit low ionic conductivity at room temperature. Nitrogen incorporation during the deposition in such oxide-based thin film amorphous materials has been studied thoroughly, since it was found to be a determinant factor for enhancing ionic conductivity [20–23]. Reports on the improvement of ionic conductivity in borates and phosphates by substitution of oxygen for nitrogen have been presented [9, 10, 24–26]. Moreover, studies on post-deposition thermal treatments have also shown improvements on the conductivity properties of glass thin films [22, 27–29].

Nevertheless, key concepts are still lacking to progress in understanding the effect of nitrogen incorporation (or annealing) on sputtered LiPON thin film properties and structure.

In this study, lithium phosphorus oxide and oxynitride amorphous thin films were prepared as a function of both gradual nitrogen incorporation and annealing treatments. Structural aspects were examined by X-ray photoelectron spectroscopy (XPS) and infrared spectroscopy (IR). Combining far- and mid-IR spectral region analysis has made evident the effect of nitrogen incorporation on both the phosphate structure and the lithium ion environment. These findings are correlated to the observed chemical stability and ionic conductivity of the studied thin films.

Experimental section

Lithium phosphates and lithium phosphorus oxynitride thin films were deposited with RF magnetron sputtering, starting from a crystalline 2-in. Li_3PO_4 target (Lesker 99.95 %). Film depositions were done in the DAISY-BAT (Darmstadt Integrated System for Battery Research), a cluster tool based on UHV technology for battery research where deposition chambers are coupled to the XPS analysis chamber [30]. Different nitrogen and argon mixtures, for a total gas flow of 10 sccm with 8×10^{-3} mbar pressure, were tested. Deposition parameters were employed to obtain film thicknesses of about 1 μm (sputtering with power density set to 2.25 W/cm^2 for 4 h) suitable for IR transmittance measurements [9, 10, 24]. Table 1 summarizes the deposition flow rates used for the experiments, from pure argon to pure nitrogen. Samples are named accordingly to the gas flow used (N_2 -Ar flow rate).

Films prepared with the highest nitrogen flow were subsequently annealed at 250, 320, and 380 $^\circ\text{C}$ in vacuum, with a base pressure of 1×10^{-7} mbar for 1 h. The Li/P ratio was determined by inductively coupled plasma atomic emission spectroscopy (ICP-AES) on a Varian 720-ES apparatus. For this purpose, LiPON films were deposited on aluminum foil for 2 h and then dissolved in acid solution for further analysis. X-ray diffraction patterns were acquired to obtain information about the amorphous nature of the films. The measurements were performed with a Seifert PTS 3003 diffractometer using a Cu anode operated at 40 mA and 40 kV and an X-ray mirror on the primary side. On the secondary side, a long Soler slit

and a graphite monochromator were used to separate the Cu K_α line.

XPS was used to determine the chemical composition of the surface of the thin films prepared. XPS was performed on each sample directly after every deposition without exposure to ambient air. All core level peaks (Li 1s, P 2p, O 1s, N 1s) and the valence band were recorded using monochromated Al K_α radiation with $h\nu = 1486.6$ eV and a pass energy of 23.50 eV.

For the structural analysis of lithium phosphates and lithium phosphorus oxynitride films, IR was used. Thin films were deposited on an undoped silicon wafer. The IR transmission spectra were recorded on a Bruker VERTEX 70v spectrometer, working under vacuum, and equipped with DTGS detectors and two beam splitters (KBr or mylar multilayer). A total of 200 scans were averaged with a resolution of 10 cm^{-1} . A glove bag was attached to the IR spectrometer for the handling and exchange of samples under nitrogen atmosphere.

In order to determine the ionic conductivity, electrochemical impedance spectroscopy was performed. For this reason, additional films were prepared on a silicon wafer with a Si/ SiO_2 / TiO_2 /Pt layer sequence (GMEK) with a top Au contact. Measurements were carried out in a Zahner IM6 potentiostat, with a frequency range of 1 MHz–1 Hz.

Results

Stability of deposited films to air exposure

The stability of samples prepared in argon and pure nitrogen was studied using infrared measurements in the transmittance mode. The IR spectra of LiPON films, which were either kept under a controlled environment or exposed to air, are shown in Fig. 1.

In all spectra, the sharp peak observed at 610 cm^{-1} corresponds to the strongest lattice mode of the silicon substrate. In the first approach, assignments of the IR bands observed in lithium phosphate thin films can be made by comparison with data reported in the literature for phosphate oxide glasses, as summarized in Table 2.

The IR spectra depicted in Fig. 1 contain all characteristic vibrations of a lithium phosphate network. The shoulder observed between 1200 and 1300 cm^{-1} is assigned to the asymmetric stretching vibrations of PO_2 , $\nu_{\text{as}}(\text{PO}_2)$, of metaphosphate units, while in the range of 900–1100 cm^{-1} , asymmetric stretching modes of pyro-, $\nu_{\text{as}}(\text{P}-\text{O}-\text{P})$ and $\nu_{\text{as}}(\text{PO}_3^{2-})$, and orthophosphate, $\nu_{\text{as}}(\text{PO}_4^{3-})$, units can be seen. The infrared bands between 700 and 850 cm^{-1} are associated with symmetric stretching modes of P–O–P linkages, while the broad band observed in the far-IR region, 200–550 cm^{-1} , is assigned to vibrations of Li cations against their sites in the oxide glass matrix [9, 10, 35–37].

Table 1 N_2 and Ar flow rates of lithium phosphate and lithium phosphorus oxynitride sputtered films

Sample (N_2 Ar flow rate)	N_2 flow rate (sccm)	Ar flow rate (sccm)
N0 10	0	10
N5 5	5	5
N10 0	10	0

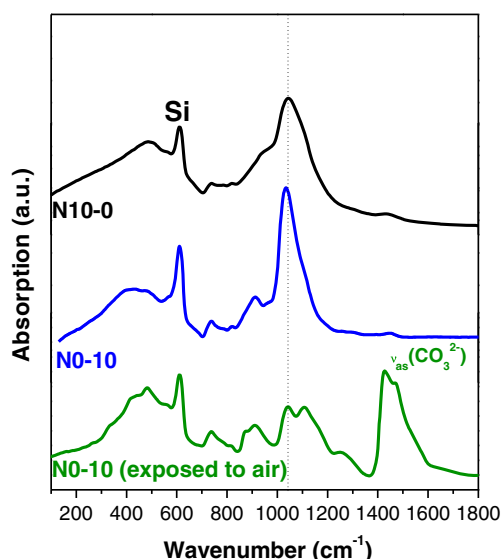


Fig. 1 IR spectra of RF sputtered thin films deposited from a Li_3PO_4 target in Ar or N_2 atmosphere (samples named N0 10 and N10 0, respectively). Films kept under N_2 and exposed to air are compared. Note that the IR spectrum of the nitrogenated film (N10 0) is not affected by air exposure

On the other hand, the lithium phosphate film (i.e., sample N0-10 deposited under Ar) presents large spectral variations after air exposure (Fig. 1). The most evident difference is observed in the region above 1250 cm^{-1} where two bands appear at 1430 and 1490 cm^{-1} . These new IR absorptions can be related to the asymmetric stretching mode of carbonate anions, $\nu_{\text{as}}(\text{CO}_3^{2-})$, as confirmed also by comparison with attenuated total reflection (ATR) measurements on Li_2CO_3 powder (not shown here). Vibrational modes of the phosphate units are also affected when the carbonate species develop: (a) the strongest peak at 1030 cm^{-1} , linked to orthophosphate units, decreases in intensity; (b) a shoulder appears at

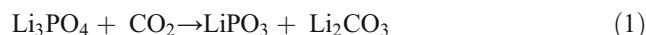
Table 2 Assignments of the main IR bands expected for amorphous lithium phosphate thin films

Wavenumber (cm^{-1})	Assignment	Reference
200 550	$\nu(\text{Li}^+ \text{ site}) (\nu_{\text{L}}, \nu_{\text{H}})$	[31]
500 600	$\delta(\text{PO}_2^-)$, $\delta(\text{O P O})$, $\delta(\text{PO}_3^{2-})$	[32 36]
720 840	$\nu_{\text{s}}(\text{P O P})$	[32 36]
Orthophosphate		
1030 1050	$\nu_{\text{as}}(\text{PO}_4^3)$	[32 36]
Pyrophosphate		
900 950	$\nu_{\text{as}}(\text{P O P})$	[32 36]
~1110	$\nu_{\text{as}}(\text{PO}_3^{2-})$	[32 36]
Metaphosphate		
840 980	$\nu_{\text{as}}(\text{P O P})$	[32 36]
1200 1300	$\nu_{\text{as}}(\text{PO}_2^-)$	[32 36]

ν_{L} low frequency components, ν_{H} high frequency components, ν_{s} asymmetric stretching modes, ν_{as} asymmetric stretching modes, δ bending modes

1250 cm^{-1} and can be attributed to $\nu_{\text{as}}(\text{PO}_2^-)$ of metaphosphate chains; (c) the spectral range $850\text{--}950 \text{ cm}^{-1}$, attributed to P–O–P vibrations, gains intensity; and (d) the far-IR band gains relative intensity and develops sharper features.

The above spectral variations manifest a higher cross-linked phosphate structure and the growth of phosphate chains. These combined spectroscopic results can be expressed by Eq. 1, which proposes the transformation of orthophosphate units (Li_3PO_4) to metaphosphate chains (LiPO_3) and formation of lithium carbonate (Li_2CO_3).



One should notice that the nitrogenated sample suffers no change under air exposure. These results are in accordance with the chemical stabilization of nitrogenated phosphates reported for both lithium and sodium compounds [5, 38, 39].

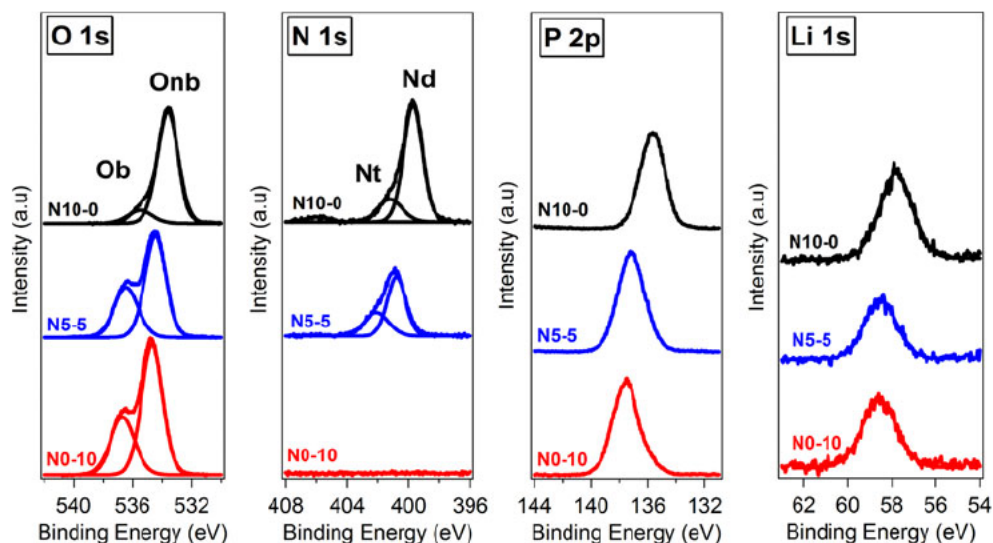
The structure of lithium phosphate oxynitride thin films and the effect of the nitrogen incorporation

The ICP-AES results obtained for the Li/P ratio of a fully nitrogenated sample (N10-0) was 2.1, with a corresponding experimental uncertainty of 10 %. This ratio evidences a lithium loss compared to the composition of the target material (Li_3PO_4) typically observed for sputtering processes.

The XPS data of O 1s, N 1s, P 2p, and Li 1s core levels from lithium phosphate oxide and oxynitride films are presented in Fig. 2. The O 1s and N 1s peaks were decomposed using a Voigt profile for samples N0-10, N5-5, and N10-0. The N 1s core level peak was fitted with two components. The deconvolution was set to doubly and triply coordinated nitrogen present in the structure, denoted by Nd and Nt, respectively. The presence of these two types of nitrogen bonding in lithium phosphorus oxynitride films has been proven and studied extensively [40–42]. The studied samples present the main peak contribution arising from nitrogen bonded to two phosphorus atoms, P–N=P, which appears at lower binding energy in the spectra. On the other hand, the shoulder observed at higher binding energies corresponds to nitrogen bonded to three phosphorus atoms, $>\text{N}-$. The energy difference between doubly bonded (Nd) and triply bonded (Nt) nitrogen was fitted to be 1.5 eV, as reported before [5, 43]. XPS peak position shifts observed in the samples are due to charging effects related to the electronically insulating nature of these oxides [42, 44].

The O 1s was also decomposed into two components. The main emission observed at low energies corresponds to the non-bridging oxygen (Onb), which can be linked to both bonding environments in P–O– Li^+ and P=O. However, it is not possible to distinguish these two species due to the resonant bonding in the phosphate tetrahedron [30, 42]. The shoulder observed at higher binding energies corresponds to

Fig. 2 XPS profile decomposition of the O 1s, N 1s, P 2p, and Li 1s peaks for N10 0, N5 5, and N0 10 samples



bridging oxygen in P–O–P linkage (Ob). The Li 1s peak shows a profile with only one lithium component contributing to the emission line. The P 2p was not fitted to identify the spin orbit splitting of the 2p orbital or to identify the different chemical environments present. Nevertheless, the results of Li 1s and P 2p peaks show symmetric profiles which become sharper with nitrogen incorporation.

Table 3 shows the evolution of the O/P and the N/P ratios as well as the Nt/Nd ratio compared to Ob/Onb ratio as a function of nitrogen incorporation. The oxygen content decreases, while the nitrogen content increases, clearly demonstrating the substitution of oxygen by nitrogen. The relative amount of Onb species tends to increase as the nitrogen content in the gas flow increases.

Figure 3a presents the infrared absorption spectra of N0-10, N5-5, and N10-0 thin films. To better visualize the spectral variations induced by the incorporation of nitrogen, Fig. 3b presents the infrared absorption difference spectra obtained from the normalized IR spectra of the three samples N0-10, N10-0, and N5-5.

All samples have a pronounced peak at 1035 cm^{-1} due to isolated PO_4^{3-} orthophosphate units, $\nu_{\text{as}}(\text{PO}_4^{3-})$. Increasing the nitrogen flow induces a pronounced decrease in intensity of this peak. On the contrary, a gain in intensity is observed at both lower (peaks at 840 and 960 cm^{-1}) and higher (peak at

1150 cm^{-1}) wavenumbers. The differences observed in the mid-IR region show how the short-range order is affected with the incorporation of nitrogen. At the first level of interpretation, the infrared spectra suggest that upon nitrogen incorporation, the network becomes more cross-linked, as depicted by the intensity decrease of the peak due to isolated PO_4^{3-} units and the intensity increase in the region of asymmetric stretching of phosphate bridges. Comparing the ν_{as} frequency of phosphate bridges, one notices differences between oxide

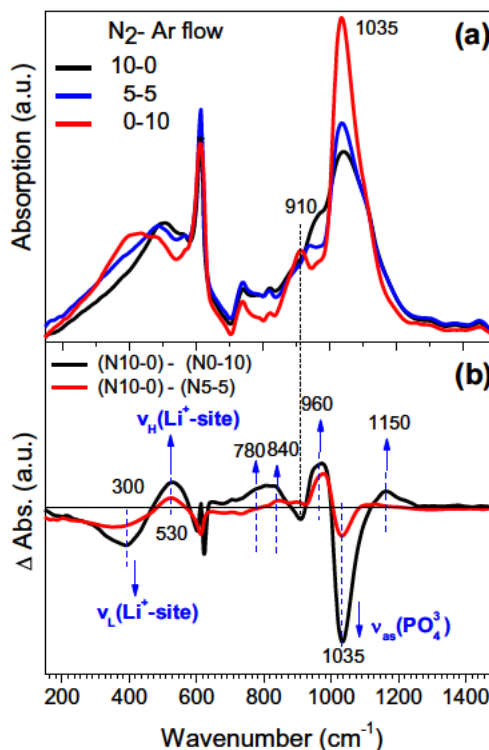


Fig. 3 a IR absorption spectra and b IR absorption difference spectra of lithium phosphorus oxide and oxynitride thin films: samples N0 10, N5 5, and N10 0

Table 3 Atomic composition and respective Nt/Nd and Ob/Onb ratios determined by XPS profile decomposition as a function of nitrogen incorporation: N0 10, N5 5, and N10 0

Sample (N ₂ Ar flow)	O/P	N/P	Ob/Onb	Nt/Nd
N0 10	3.3		0.5	
N5 5	2.5	0.5	0.5	0.5
N10 0	2.2	0.9	0.1	0.3

and oxynitride networks; in the pure oxide film, $\nu_{\text{as}}(\text{P-O-P})$ appears at 910 cm^{-1} i.e., just in between the two components observed for the oxynitride case at 840 and 960 cm^{-1} (Fig. 3). The assignments of possible P-N vibrations will be done in the “Discussion” section.

Focusing on the far-IR region, the broad envelope due to lithium cation vibrations against their sites becomes narrower and the apparent maximum shifts from 400 to 500 cm^{-1} as nitrogen is progressively incorporated in the oxynitride film. This variation evidences a strong influence of nitrogen incorporation on the environments hosting the lithium cations. Kamitsos et al. [31] have observed for alkali oxide-containing glasses the occurrence of more than one cation motion band in the far-IR originating from the existence of more than one type of cation-hosting anionic sites differing mainly in the coordination of alkali cation. Following this methodology, the far-IR envelope has been analyzed using spectral decomposition based on similar treatments for the far-IR spectra reported for borate, phosphate, and germanate glasses [31, 35, 36, 44, 45]. Figure 4 presents the decomposition of the far-IR region for samples N0-10, N5-5, and N10-0. Peaks corresponding to the Si substrate and to phosphate deformation modes were fixed to 610 and 590 cm^{-1} , respectively. The fitting procedure gives satisfactory results with two broad bands peaking at 460 and 330 cm^{-1} for the Li phosphorus oxide film (Fig. 4a) and at 500 and 380 cm^{-1} for the Li phosphorus oxynitride film (Fig. 4b, c). The narrowing effect

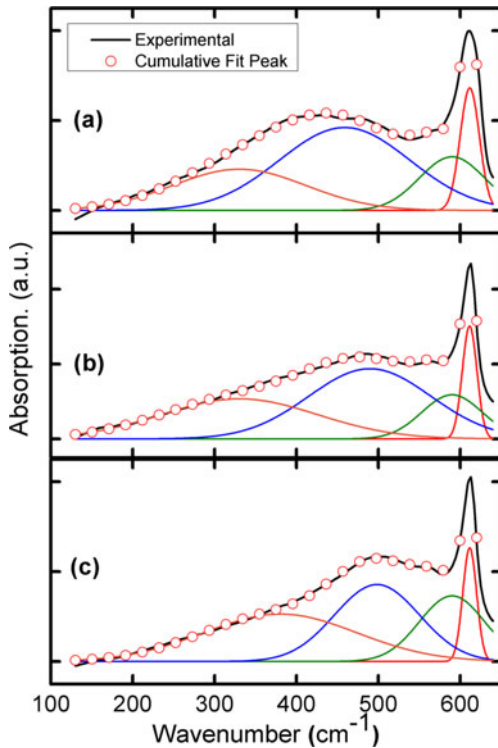


Fig. 4 Spectral decomposition of the far IR region for **a** non nitrogenated (N0 10), **b** partially nitrogenated (N5 5), and **c** fully nitrogenated (N10 0) lithium phosphorus oxynitride thin films

observed on the global far-IR envelope is due to a 65 % decrease of the high-frequency component bandwidth, whereas it remains unchanged for the low-frequency component.

Annealing effect on LiPON thin film structure

The samples discussed in this section were deposited under nitrogen atmosphere using the same deposition conditions as for sample N10-0 in Table 3. After deposition, thin films were immediately annealed under vacuum (base pressure of 1×10^{-7} mbar) for 1 h at $T_A = 250, 320$, and $380 \text{ }^\circ\text{C}$. Subsequently, IR measurements were performed under controlled atmospheres. However, the spectral features observed for all samples were similar, and we will present in this section only the results for the film annealed at $250 \text{ }^\circ\text{C}$.

XRD measurements were performed on the as-deposited and annealed ($250 \text{ }^\circ\text{C}$) samples. The diffraction patterns, shown in Fig. 5 and compared to bare silicon substrate, evidence the amorphous structure of the films with a characteristic broad peak around 22° [11]. The annealed sample additionally showed an increase in intensity reflection, possibly due to a minor gain in ordering of the network, but maintaining the overall peak broadness and thus amorphous nature.

Annealed lithium phosphorus oxynitride thin films were further analyzed with IR spectroscopy. Figure 6a presents the absorption spectra of the as-deposited and annealed oxynitride samples. The spectral variations induced by the post-deposition treatment are presented in Fig. 6b. Similar to nitrogen incorporation, illustrated in the previous section, infrared absorption difference spectra were calculated from the normalized IR spectra of the as-deposited and annealed samples by subtracting the corresponding spectra of films N0-10 (Ar deposition) and N10-0 (N_2 deposition), respectively.

When compared to the as-deposited sample, the annealed layer gives similar IR signature. The minor changes seen at the mid-IR regions with thermal treatment (Fig. 6a) correspond to modifications in the short-range order, evidenced by an increased amount of isolated PO_4^{3-} units (peak at 1040 cm^{-1}). The region

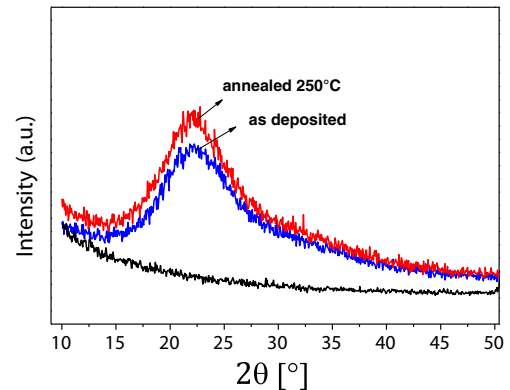


Fig. 5 XRD patterns for as deposited and annealed ($250 \text{ }^\circ\text{C}$) sputtered LiPON thin film

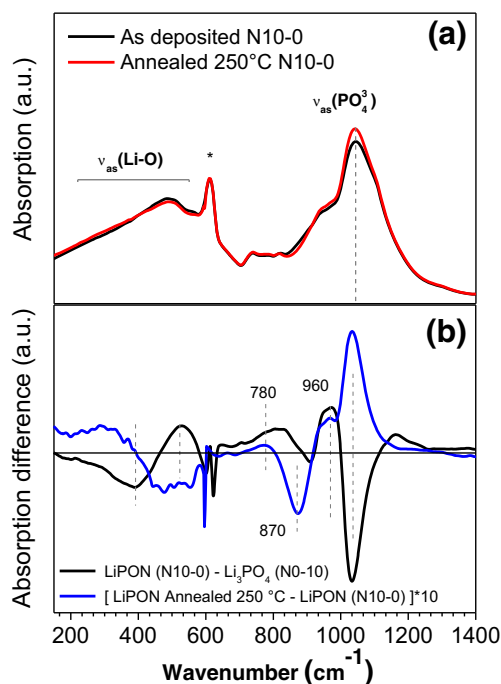


Fig. 6 **a** IR spectra of lithium phosphorus oxynitride thin film as deposited and annealed at 250 °C and **b** infrared absorption difference spectra of as deposited and annealed samples obtained by subtracting the absorption spectra of thin films deposited under Ar (N0 10) or N₂ flow (N10 0). Note that the absorption difference spectra obtained after annealing has been multiplied by 10 to allow relative spectral comparison

linked to the stretching of phosphate bridges is also influenced (Fig. 6b), with an increase observed at high frequency (960 cm⁻¹) and a decrease at lower wavenumbers (870 cm⁻¹).

In the far-IR, slight changes can be observed related to the two components forming the broad envelope linked to the lithium ion site vibrations. As shown in the difference spectrum (Fig. 6b), the high-frequency component peaking at 500 cm⁻¹ has decreased upon annealing, whereas the low-frequency component has increased.

Comparing the annealing-induced spectral changes to the modifications due to the nitrogen incorporation, we observe an opposite trend concerning both the content of orthophosphate units and the far-IR region. Concerning the asymmetric stretching modes of phosphate bridges (800–1000 cm⁻¹), the annealing treatments have modified the relative absorption of the low- and high-frequency components which were both observed upon nitrogen incorporation.

Additional films for the ionic conductivity determination were prepared on a silicon wafer with Si/SiO₂/TiO₂/Pt layers, deposited and annealed for the same time as films for IR measurements. An Au contact was sputtered on the resulting films to act as top contact for EIS measurements. Unfortunately, cracking of the oxynitride (LiPON) film was observed for samples annealed at 320 and 380 °C preventing the determination of the ionic conductivity due to shorts. Table 4 presents the ionic conductivity values of the as-

Table 4 Room temperature ionic conductivities of as deposited and annealed (250 °C) lithium phosphorus oxynitride thin films

Sample	Ionic conductivity (S/cm)
Li ₃ PO ₄	0.6 3.3 × 10 ⁻⁷ [7]
LiPON	1.0 × 10 ⁻⁶
LiPON (annealed 250 °C)	2.1 × 10 ⁻⁶

deposited and annealed (250 °C) LiPON layers compared to values reported in the literature [7].

The effect of the annealing process resulted in an increase in ionic conductivity, as can be seen in Table 4. As observed in the IR measurements, for the annealed sample (Fig. 6), thermal-induced formation of isolated units (PO₄³⁻) and changes in Li⁺ cation vibration trends are opposite to the modifications resulting from nitrogen incorporation, both having a positive effect on the ion mobility [20–23]. Nevertheless, it is important to note that the origin of the changes observed in each case corresponds to different phenomena. On one hand, nitrogen incorporation induces a complete new oxynitride structure, which will be discussed later, while the thermal treatment produces relaxation of constraints present in the “hyperquenched” film and minor structural rearrangements.

Discussion

To describe the phosphate structure of the oxynitride films studied in this work, the first step is to get knowledge on both lithium and nitrogen content. Chemical composition and structure obtained by ICP and IR spectroscopy, respectively, agree on a loss of lithium compared to the composition of the target. In terms of IR spectroscopy, the oxide phosphate structure can be clearly described as a mixture of orthophosphate and pyrophosphate units.

Upon nitrogen incorporation during sputtering, the chemical bonding of the phosphate matrix should change progressively. For a fixed amount of lithium ions, every two nitrogen ions (N³⁻) bonded to the phosphate matrix will remove three oxygen ions (O²⁻) from the structure to maintain charge neutrality. Depending on the nature of bonding of the removed oxygen, nitrogen can be incorporated in doubly coordinated (=N–) and triply coordinated (–N<) sites with phosphorus atoms. To determine nitrogen content and its coordination, XPS is a very powerful tool. Our data in this work are in good agreement with previous reports from literature. At the maximum of our nitrogen incorporation process, the N/P ratio is close to 1 (sample N10-0, Table 3) and we estimate that about 75 % of the total nitrogen amount is doubly bonded (=N–). Moreover, for the highest amount of nitrogen incorporated, XPS has evidenced a very low amount of bridging oxygen in the oxynitride phosphate matrix (about 10 %). In IR

spectrum, however, the characteristic band of isolated orthophosphate units has decreased in intensity, while an intensity increase in the region of asymmetric stretching of phosphate bridges was observed. In a comparison of XPS and IR data, it must be stated that the relative intensities in XPS are semi-quantitative amounts on surface compositions, whereas the changes in IR correspond to qualitative observations of bulk properties. Then, in accordance with literature [5, 13, 41, 43], the data indicate that nitrogen is mainly doubly bonded and related to the formation of bridges between phosphate tetrahedral units.

Figure 7 shows the propositions of oxide and oxynitride structural units in which the nitrogen incorporation simply consists of substitution of bridging oxygen by doubly bonded nitrogen. As noted above, due to the loss of lithium ions during the deposition process, the oxide network is formed as a mixture of orthophosphate and pyrophosphate units, which are depicted in Fig. 7(a, b), respectively.

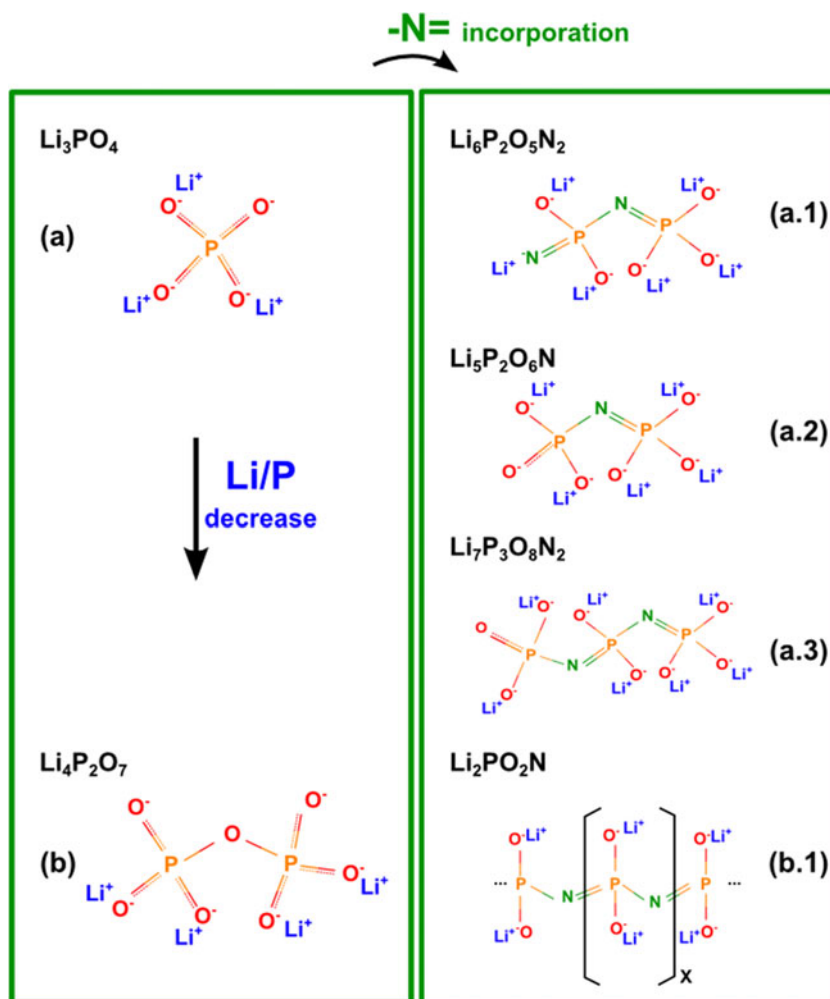
Then, depending on the value of the Li/P ratio, several oxynitride units can be proposed. With a ratio value of Li/P=2, the oxynitride entity corresponding to pyrophosphate

is $\text{Li}_2\text{PO}_2\text{N}$ (see Fig. 7(b.1)). For such a lithium concentration, the incorporation of doubly bonded nitrogen forms a chain structure. Interestingly, if one compares oxide and oxynitride chain structures, i.e., the metaphosphate LiPO_3 and $\text{Li}_2\text{PO}_2\text{N}$, the concentration of lithium is doubled in the oxynitride. Decreasing the size of the chain permits to increase the Li/P ratio. For Li/P=3, corresponding to the orthophosphate oxide, an oxynitride dimer possessing one non-bridging nitrogen is needed ($\text{Li}_6\text{P}_2\text{O}_5\text{N}_2$ in Fig. 7(a.1)).

Finally, following the experimental evidences showing that nitrogen incorporation is mainly related to the substitution of bridging oxygen by doubly bonded nitrogen, the phosphate network might be described by a mixture of orthophosphate oxide Li_3PO_4 , with oxynitride dimer, trimer, and chain structures, depending on the Li/P ratio.

Nevertheless, one should note that for the orthophosphate oxynitride case (i.e., $\text{Li}_6\text{P}_2\text{O}_5\text{N}_2$), there is neither proof in XPS or IR of non-bridging nitrogen in our thin films nor experimental proof of its existence in literature. Thus, we do not expect this particular entity in our oxynitride films, notably because of the lithium deficiency. However, oxynitride dimer

Fig. 7 Proposed clusters for nitrogen incorporation to lithium diphosphate (a.1 and a.2) and triphosphate (a.3) units and to lithium poly phosphate chains (b.1)



and chain structures were studied by first-principle simulations [47]. Similarly to our propositions, Du and Holzwarth have computed the structure and the related vibrational spectra of a $\text{Li}_5\text{P}_2\text{O}_6\text{N}$ dimer and $\text{Li}_2\text{PO}_2\text{N}$ chains. The vibrational modes with the largest involvement of bridging N were calculated at 780 and 1130 cm^{-1} in the dimer material $\text{Li}_5\text{P}_2\text{O}_6\text{N}$ and at 850 and 1120 cm^{-1} in the infinite chain material $\text{Li}_2\text{PO}_2\text{N}$.

The agreement with our experimental data is satisfactory, as observed in the difference spectrum (N10-0)-(N0-10) of Fig. 3 showing an increase of absorption upon nitrogen incorporation at 780, 840, 960, and 1150 cm^{-1} . Similarly to the assignments done for oxide phosphate materials in forms of chains or dimers (see Table 1), it could be possible to assign (i) the low-frequency peaks (i.e., 780, 840 cm^{-1}) to asymmetric stretching of P–N–P bridges in short and long chains, respectively, and (ii) the peak at higher frequency (1150 cm^{-1}) to N–P–O stretching vibrations involving a non-bridging oxygen.

The peak observed at 960 cm^{-1} is not predicted by the calculations of Du and Holzwarth of lithium oxynitride chains and dimers [47, 48]. However, as detailed above, the oxynitride structure may tend to form long phosphate chains if the value of the Li/P ratio is close to 2. In such a case, a comparison with oxide metaphosphate glasses suggests the possibility of forming ring structures in the oxynitride network [35, 36]. Spectral assignments done in the literature for metaphosphate oxide compositions predict the asymmetric stretching of phosphate bridges in ring structures at higher frequency in comparison to chains [35, 36]. Therefore, the absorption band increasing at 960 cm^{-1} with nitrogen incorporation might be attributed to the presence of rings. In addition, we have observed rearrangements in the spectral domain of phosphate bridges and an increase of the number of Li_3PO_4 orthophosphate units after annealing treatments. Following our proposition of assignments, these spectral changes could be linked to the rearrangement of long phosphate chains (decrease at 870 cm^{-1}) into smaller ones or into rings (increase at 960 cm^{-1}), which can liberate an isolated orthophosphate unit (increase at 1050 cm^{-1}). An example of such a structural modification is proposed in Fig. 8.

The effect of nitrogen incorporation on the lithium environment can be evaluated by analyzing far-infrared absorption

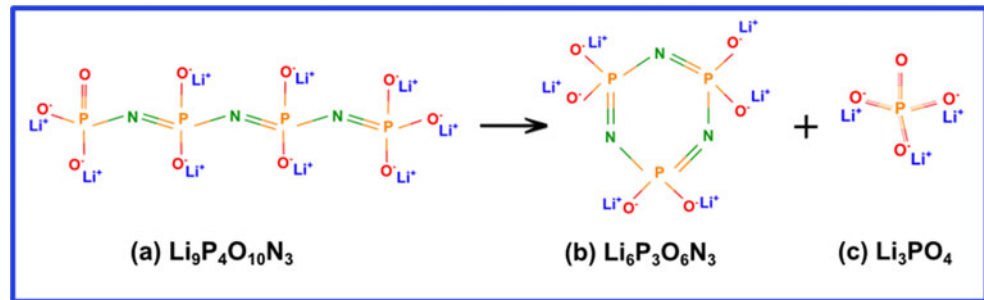
bands linked to cations motions. As reported for numerous modified glassy systems, we can describe the spectral profile in this region by at least two contributions, at low and high frequency, corresponding to metal cations in at least two distributions of anionic sites. The high-frequency component has been found to be similar to cation vibrations observed in the corresponding crystals [31, 45]. The low-frequency component was attributed to less favored sites in glass with a higher cation coordination number and a lower negative charge density. It was shown in Fig. 3 that the main effects of nitrogen incorporation on the far-IR absorption are a shift to higher frequency and a narrowing of the high-frequency component. As a first remark, the important narrowing effect (65 % decrease of the high-frequency component bandwidth) observed for the cation motion band denotes a large increase of the metal ion site distribution uniformity and thus a considerable ordering of the local structure around the lithium cations.

Concerning the frequency shift, far-IR spectroscopy is established to be a direct and sensitive tool to study the anionic environment of alkali metal ions [31, 45, 46]. This has been proven by correlating optical basicity and cation motion frequency in several glassy systems [31, 45, 46]. If we consider the interactions between Li^+ cations and the anionic sites of the oxynitride network as purely ionic (i.e., those interactions should not involve covalency), the cation site vibration can be considered as simple harmonic and the frequency of the mode can be determined using the force constant and the reduced mass of the vibrating cation site system. This force constant can be obtained from the expressions of the electrostatic and repulsive interactions of alkali cations in their site and an analytical form of the frequency of the cation site vibration is obtained, as detailed in [49]:

$$\nu^2 = \left(\frac{\alpha}{48\pi^3 c^2 \epsilon_0} \right) \frac{q_C q_A}{\mu r_0^3} \left(\frac{r_0}{\rho} - 2 \right)$$

where ν is the frequency of the cation site vibration, q_C and q_A are the charges of cation and anionic site, μ is the reduced mass of vibration, r_0 is the cation site equilibrium distance, c is the speed of light, ϵ_0 the permittivity of free space, α the pseudo-Madelung constant, and ρ is the repulsion parameter [49]. In a first approximation, one can consider that q_C , r_0 , and μ do not vary from the oxide to the oxynitride lithium

Fig. 8 Proposed clusters for rearrangements of phosphate chains (a) into ring (b) and orthophosphate (c) units



phosphate network. Then, the shift of cation site vibration to higher frequency can be attributed to an increase of the negative charge density q_A at the anionic site. In the present case, the anionic site is dominated by the charge density at the associated non-bridging oxygen, but is also influenced by bridging oxygen or bridging nitrogen atoms in the vicinity. As shown by the oxynitride structure calculated by Du and Holzwarth, the influence of bridging nitrogen on the lithium environment is much stronger than for bridging oxygen [47, 48]. Their calculations showed that Li tends to be close to bridging N in oxynitride as compared to bridging O in pure phosphorus oxide network. It depicts a non-negligible ionic interaction between Li^+ cation and bridging nitrogen center. As proposed by Du and Holzwarth, one may consider a more general view concerning the bonding nature of the nitrogen in lithium phosphorus oxynitride network, where a possible scenario would be a nitrogen atom linked with two covalent bonds to phosphorus atoms and a weak ionic bond to lithium. The proposed assignation for the IR bands for oxynitride films are presented in Table 5. These results show how P–N–P bridges appear at similar or lower frequencies compared to the P–O–P bridges in the oxide, evidencing how the force constant observed for the P–N bonds is similar or lower than the P–O bonds. However, the expected force constant of N with a double bond should be drastically higher, which is not observed in our IR results. Therefore, this is an indirect confirmation that the bonding nature of N should not be considered as divalent, but should rather take in account the non-negligible ionic interaction between N and Li^+ . The ionic interaction, which is much stronger for bridging nitrogen as compared to bridging oxygen, will tend to increase the negative charge density in the Li^+ site of an oxynitride network and cause the shift to higher frequency observed in the far-IR. This manifests the strong role of doubly covalently bonded bridging nitrogen on the lithium sites, which leads to increase strength of lithium interactions with its anionic site and decrease the related P–N–P force constant.

Finally, one may correlate the information obtained on the nature of the oxynitride phosphate network and the lithium environment with the enhanced properties of the LiPON films, i.e., improved chemical stability and increased ionic

conductivity. For the oxide network, we have demonstrated that the chemical instability of the electrolyte is linked to the strong reactivity of lithium cations and oxide anions, which are released from the orthophosphate to pyrophosphate transformation (see Eq. 1). The chemical stability of the oxynitride films can be directly correlated to information obtained from far-IR for (i) stronger interactions between lithium cation and its anionic site (shift to higher frequency) and (ii) increase of the local network ordering around lithium ions (narrowing of the cation motion bandwidth). As for the improved Li ion transport in the case of phosphorus oxynitride networks, one should consider the redistribution of the negative charge on the phosphate network which determines the energy barriers limiting lithium ion hopping. The stronger involvement of bridging nitrogen atoms in the coordination sphere of lithium ions provides a better distribution of the negative charge density along the phosphate dimer or chain structures as compared to oxide network where the negative charge is mainly located on the non-bridging oxygen sites. In addition, charge delocalization through collective effect along the phosphonitride chains might play a role in improving the lithium ion mobility by inducing a “flexibility” of the negative charge density on the network.

Conclusions

In this paper, we have investigated the structure of LiPON thin films by XPS and IR spectroscopy, offering complementary information. XPS allows unambiguous distinction of different nitrogen (oxygen) bonding environments and delivers insights regarding composition (determination of O/P and N/P ratios). On the other hand, IR spectroscopy is sensitive to the type of structural units present in the film and allows detecting changes in the lithium environment. Combining the results of the two analysis techniques on sputtered films with different nitrogen content, we have proposed specific structural units present in the oxynitride films and discussed the effect of nitrogen incorporation on lithium environment, reactivity, and conductivity.

Table 5 Proposed assignation for IR bands for amorphous sputtered lithium phosphorus oxynitride thin films

Oxide		Oxynitride		
Wavenumber (cm^{-1})	Assignment	Wavenumber (cm^{-1})	Assignment	Cluster ^a
330, 460	$\nu(\text{Li}^+ \text{ site}) (\nu_L, \nu_H)$	380, 500	$\nu(\text{Li}^+ \text{ site}) (\nu_L, \nu_H)$	
910	$\nu_{\text{as}}(\text{P O P})$ pyrophosphate	780	$\nu_{\text{as}}(\text{P N P})$ short chains	7a.2
1035	$\nu_{\text{as}}(\text{PO}_4^3)$	840	$\nu_{\text{as}}(\text{P N P})$ long chains	7b.1
1150	$\nu_{\text{as}}(\text{PO}_3^2)$	960	$\nu_{\text{as}}(\text{P N P})$ rings	8b
		1150	$\nu_{\text{as}}(\text{N})\text{P Onb}$	

^a Clusters from Figs. 7 and 8

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